

Notice of References Cited	Application/Control No. 09/842,596		Applicant(s)/Patent Under Reexamination SHANTHAVEERIAIAH ET AL.	
	Examiner Sargon N. Nano		Art Unit 2157	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,920,491	07-2005	Kim, Hyon T.	709/220
*	B	US-6,965,951	11-2005	Kim, Hyon T.	710/19
*	C	US-7,002,905	02-2006	Khouri et al.	370/216
*	D	US-6,519,062	02-2003	Yoo, Sung-Joo	398/49
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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